

PATENT APPLICATION

Sheet 1 of 1

FORM PTO-1449	ATTY. DOCKET NO. 200208959-1	APPLICATION NO. 10/614,504	CONFIRMATION NO.
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT	APPLICANT Frederick A. Perner		
(Use several sheets if necessary)	FILING DATE herewith	GROUP 2818	

REFERENCE DESIGNATION

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	PUBLICATION DATE	NAME	Pages, Columns, Lines Where Relevant Passages or Figures Appear
<i>P</i>	1A	6,169,686B1	Jan. 2, 2001	Brug et al.	<i>2</i>
	1B	6,259,644B1	Jul. 10, 2001	Tran et al.	
	1C	6,567,297 B2	May 20, 2003	R. Jacob Baker	
	1D	2002/0101758	Aug. 1, 2002	R. Jacob Baker	
<i>P</i>	1E	2003/0039162	Feb. 27, 2003	R. Jacob Baker	
	1F				
	1G				
	1H				
	1I				
	1J				
	1K				

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	PUBLICATION DATE	NAME OF PATENTEE OR APPLICANT	Pages/Columns/Lines Where Relevant Passages/Figures Appear	Check if Translation attached
<i>1L</i>					
<i>1M</i>					
<i>1N</i>					
<i>1O</i>					
<i>1P</i>					

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

<i>P</i>	1Q	"Nonvolatile RAM based on Magnetic Tunnel Junction Elements" by M. Durlam et al. 2000 IEEE International Solid-State Circuits Conference 07803-5853-8/00, Motorola Labs, Physical Sciences Research Labs, Tempe, AZ, Section TA 7.3
<i>P</i>	1R	"A 10ns Read and Write Non-volatile Memory Array Using a Magnetic Tunnel Junction and FET Switch in each Cell" by Roy Scheuerlein et al. 2000 IEEE International Solid-State Circuits Conference 07803-5853-8/00, IBM Research Almaden Research Center, San Jose, CA, Section TA 7.2
<i>P</i>	1S	"Offset Compensating Bit-Line Sensing Scheme for High Density DRAM's" by Yohi Watanabe et al., IEE Journal of Solid-State Circuits, Vol. 29, No. 1, January 1994.

EXAMINER

*Sare Auduong*

DATE CONSIDERED

*9/04*